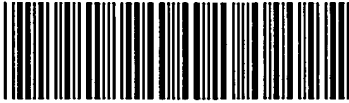


Search Notes

Application/Control No.

10/766,322

Examiner

Jay M. Patidar

Applicant(s)/Patent under
Reexamination

MIYA ET AL.

Art Unit

2862

SEARCHED

Class	Subclass	Date	Examiner
324	207.12	11/22/2005	JP
	207.15		
	207.16		
	207.17		
	207.25		
318	653		
	661		
310	168		
	68B		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST searched.	11/22/2005	JP